

Notice of References Cited

Application/Control No.

10/511,917

Applicant(s)/Patent Under
Reexamination
KOCK ET AL.

Examiner

Toan C. To

Art Unit

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0245761	12-2004	Maloney et al.	280/801.1
*	B	US-2004/0111846	06-2004	Itoigawa et al.	024/633
*	C	US-2004/0060761	04-2004	Almaraz et al.	180/268
*	D	US-2003/0155166	08-2003	Sullivan et al.	180/268
*	E	US-7,144,042	12-2006	Eichwald, Tor Vopn	280/805
*	F	US-7,021,162	04-2006	Ante et al.	73/862.391
*	G	US-7,007,976	03-2006	Ante et al.	280/801.1
*	H	US-7,000,488	02-2006	Ante et al.	73/862.391
*	I	US-6,820,458	11-2004	Grzic, Rudi	73/1.15
*	J	US-6,793,032	09-2004	Lichtinger et al.	180/268
*	K	US-6,746,048	06-2004	Tajima et al.	280/801.1
*	L	US-6,679,524	01-2004	Greib et al.	280/801.1
*	M	US-6,566,869	05-2003	Chamings et al.	324/207.26

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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